Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/553,040	INOUE ET AL.
Examiner	Art Unit
F. Daniel Lopez	3745

	SEAR	CHED	
Class	Subclass	Date	Examiner
91	369.2	1/30/2007	FDL

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARC (INCLUDING SEA	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
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